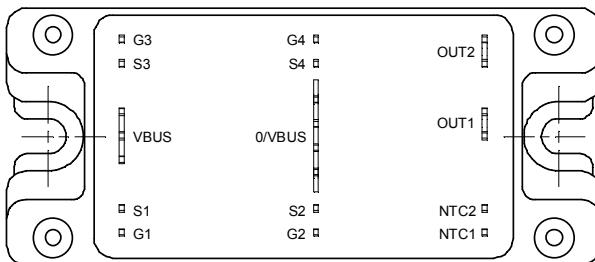
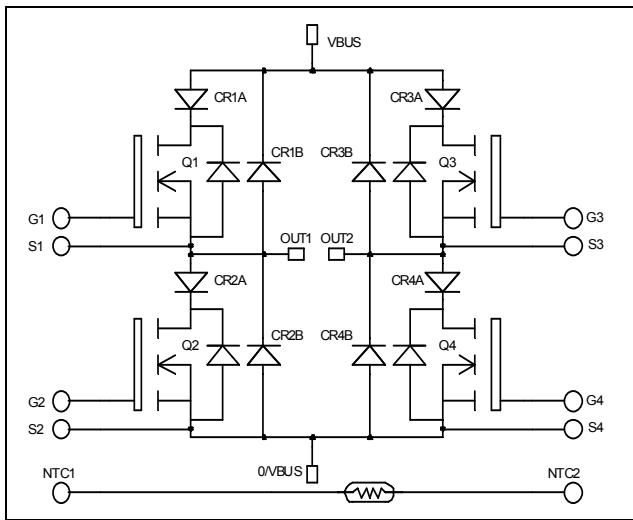


**Full - Bridge
Series & SiC parallel diodes
Super Junction
MOSFET Power Module**



Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V_{DSS}	Drain - Source Breakdown Voltage	600	V
I_D	Continuous Drain Current	$T_c = 25^\circ\text{C}$	A
		$T_c = 80^\circ\text{C}$	
I_{DM}	Pulsed Drain current	156	
V_{GS}	Gate - Source Voltage	± 30	V
R_{DSon}	Drain - Source ON Resistance	70	$\text{m}\Omega$
P_D	Maximum Power Dissipation	$T_c = 25^\circ\text{C}$	W
I_{AR}	Avalanche current (repetitive and non repetitive)	20	A
E_{AR}	Repetitive Avalanche Energy	1	mJ
E_{AS}	Single Pulse Avalanche Energy	1800	

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed.

$V_{DSS} = 600\text{V}$

$R_{DSon} = 70\text{m}\Omega \text{ max @ } T_j = 25^\circ\text{C}$

$I_D = 39\text{A} @ T_c = 25^\circ\text{C}$

Application

- Motor control
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

Features

- **COOLMOS® Power Semiconductors**
 - Ultra low R_{DSon}
 - Low Miller capacitance
 - Ultra low gate charge
 - Avalanche energy rated
- **Parallel SiC Schottky Diode**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF
- Kelvin source for easy drive
- Very low stray inductance
 - Symmetrical design
 - Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
BV_{DSS}	Drain - Source Breakdown Voltage	$V_{\text{GS}} = 0\text{V}, I_{\text{D}} = 250\mu\text{A}$	600			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 600\text{V}$	$T_j = 25^\circ\text{C}$		25	μA
		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 600\text{V}$	$T_j = 125^\circ\text{C}$		250	
$R_{\text{DS(on)}}$	Drain – Source on Resistance	$V_{\text{GS}} = 10\text{V}, I_{\text{D}} = 19.5\text{A}$			70	$\text{m}\Omega$
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}} = V_{\text{DS}}, I_{\text{D}} = 1\text{mA}$	2.1	3	3.9	V
I_{GSS}	Gate – Source Leakage Current	$V_{\text{GS}} = \pm 20\text{ V}, V_{\text{DS}} = 0\text{V}$			± 100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 25\text{V}$ $f = 1\text{MHz}$		7015		pF
C_{oss}	Output Capacitance			2565		
C_{rss}	Reverse Transfer Capacitance			212		
Q_g	Total gate Charge	$V_{\text{GS}} = 10\text{V}$ $V_{\text{Bus}} = 300\text{V}$ $I_{\text{D}} = 39\text{A}$		259		nC
Q_{gs}	Gate – Source Charge			29		
Q_{gd}	Gate – Drain Charge			111		
$T_{\text{d(on)}}$	Turn-on Delay Time	Inductive switching @ 125°C $V_{\text{GS}} = 15\text{V}$ $V_{\text{Bus}} = 400\text{V}$ $I_{\text{D}} = 39\text{A}$ $R_G = 5\Omega$		21		ns
T_r	Rise Time			30		
$T_{\text{d(off)}}$	Turn-off Delay Time			283		
T_f	Fall Time			84		
E_{on}	Turn-on Switching Energy	Inductive switching @ 25°C $V_{\text{GS}} = 15\text{V}, V_{\text{Bus}} = 400\text{V}$ $I_{\text{D}} = 39\text{A}, R_G = 5\Omega$		402		μJ
E_{off}	Turn-off Switching Energy ①			980		
E_{on}	Turn-on Switching Energy			657		μJ
E_{off}	Turn-off Switching Energy ①	Inductive switching @ 125°C $V_{\text{GS}} = 15\text{V}, V_{\text{Bus}} = 400\text{V}$ $I_{\text{D}} = 39\text{A}, R_G = 5\Omega$		1206		

① In accordance with JEDEC standard JESD24-1.

Series diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{\text{F(AV)}}$	Maximum Average Forward Current	50% duty cycle	$T_c = 85^\circ\text{C}$		30	A
V_F	Diode Forward Voltage	$I_F = 30\text{A}$			1.1	V
		$I_F = 60\text{A}$			1.4	
		$I_F = 30\text{A}$	$T_j = 125^\circ\text{C}$		0.9	
t_{rr}	Reverse Recovery Time	$I_F = 30\text{A}$	$T_j = 25^\circ\text{C}$		24	ns
		$V_R = 133\text{V}$ $\text{di}/\text{dt} = 200\text{A}/\mu\text{s}$	$T_j = 125^\circ\text{C}$		48	
Q_{rr}	Reverse Recovery Charge	$I_F = 30\text{A}$	$T_j = 25^\circ\text{C}$		33	nC
		$V_R = 133\text{V}$ $\text{di}/\text{dt} = 200\text{A}/\mu\text{s}$	$T_j = 125^\circ\text{C}$		150	

Parallel diode ratings and characteristics

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>		<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
I _{F(AV)}	Maximum Average Forward Current	50% duty cycle	T _c = 125°C		20		A
V _F	Diode Forward Voltage	I _F = 20A	T _j = 25°C		1.6	1.8	V
			T _j = 175°C		2.0	2.4	
Q _C	Total Capacitive Charge	I _F = 20A, V _R = 300V di/dt = 800A/μs			28		nC
Q	Total Capacitance	f = 1MHz, V _R = 200V			130		pF
		f = 1MHz, V _R = 400V			100		

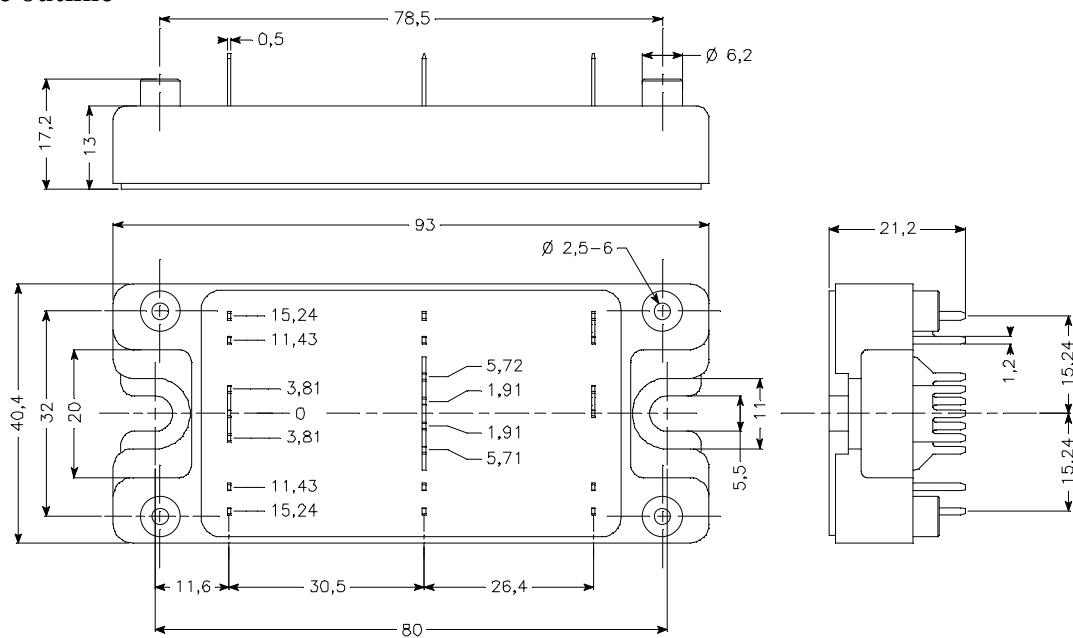
Thermal and package characteristics

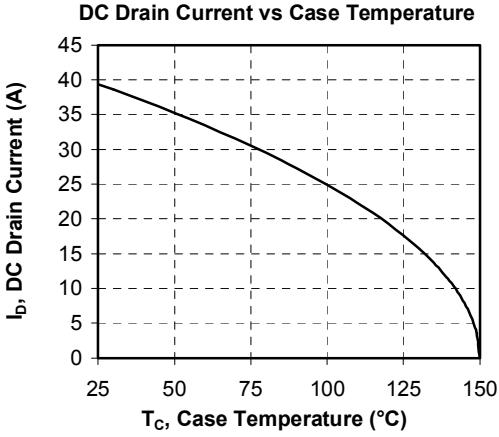
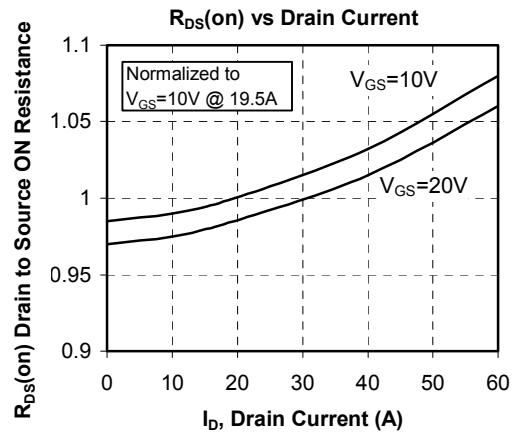
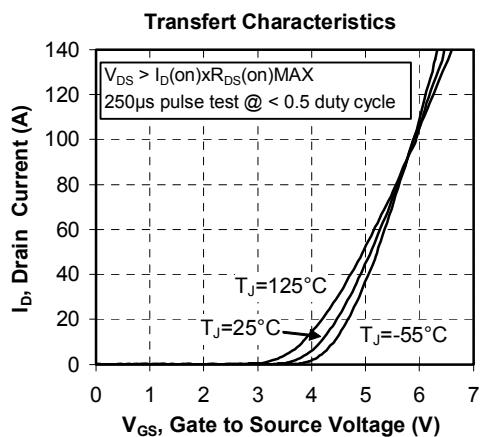
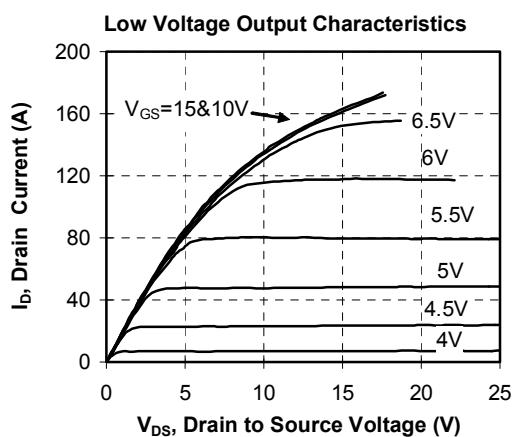
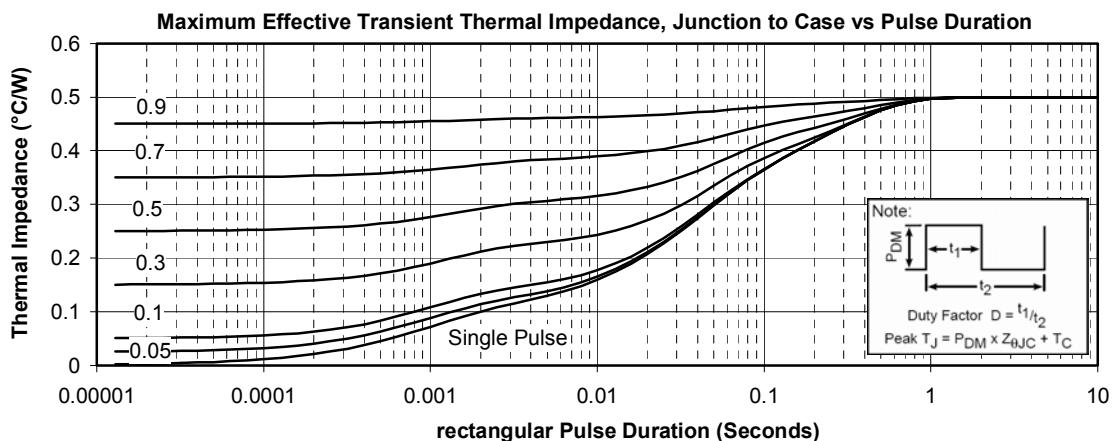
<i>Symbol</i>	<i>Characteristic</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
R _{thJC}	Junction to Case	Transistor		0.5	°C/W
		Series diode		1.2	
		Parallel diode		1.5	
V _{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, I _{isol} <1mA, 50/60Hz	2500			V
T _J	Operating junction temperature range	-40		150	°C
T _{STG}	Storage Temperature Range	-40		125	
T _C	Operating Case Temperature	-40		100	
Torque	Mounting torque	To Heatsink	M5		N.m
Wt	Package Weight			160	g

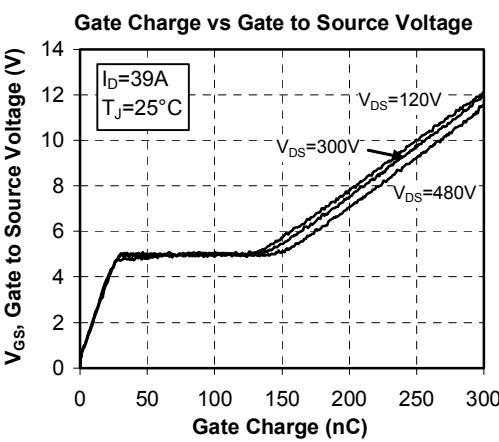
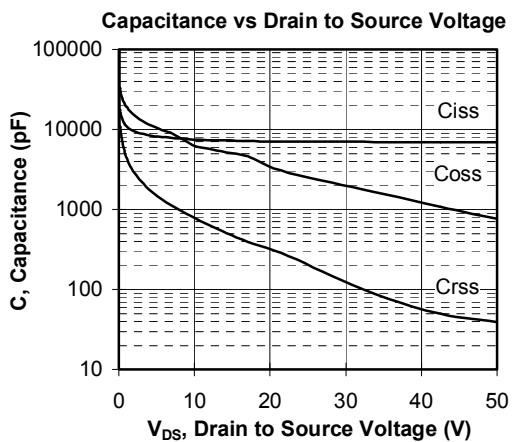
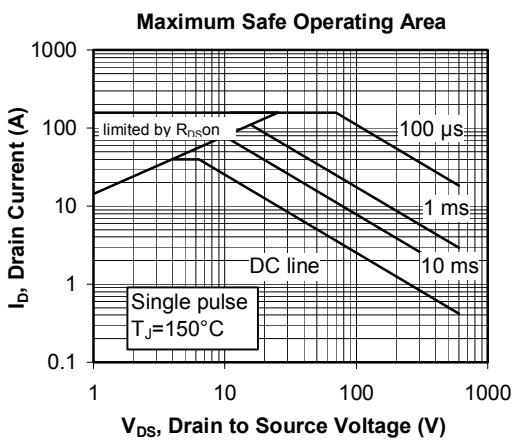
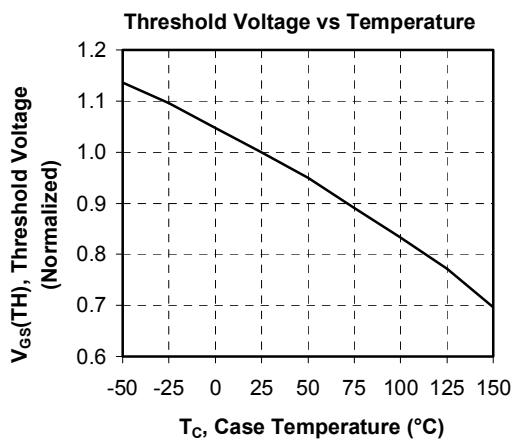
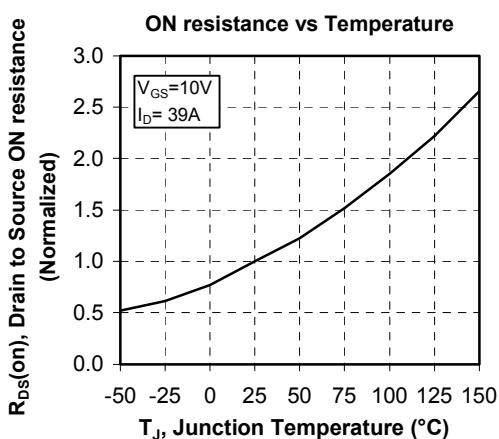
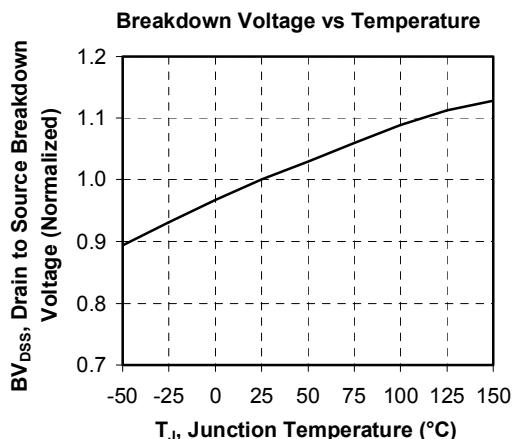
Temperature sensor NTC

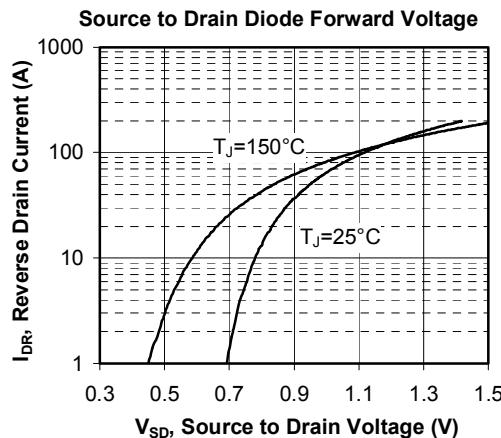
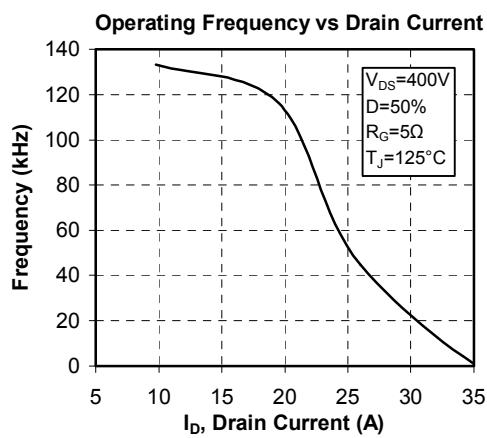
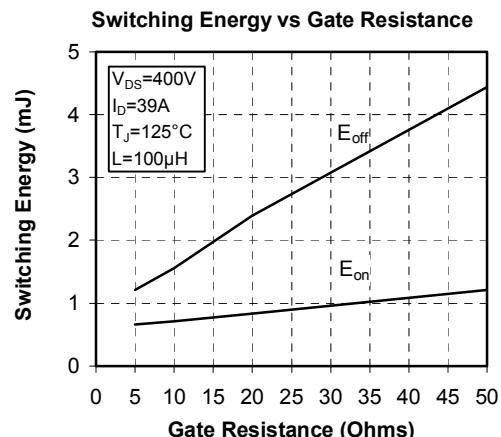
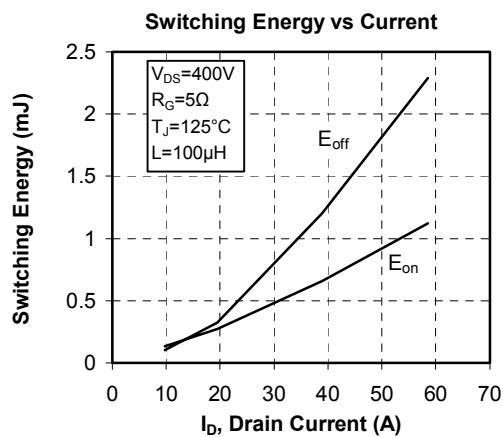
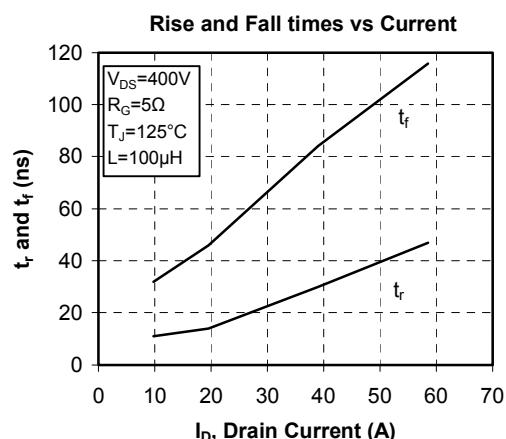
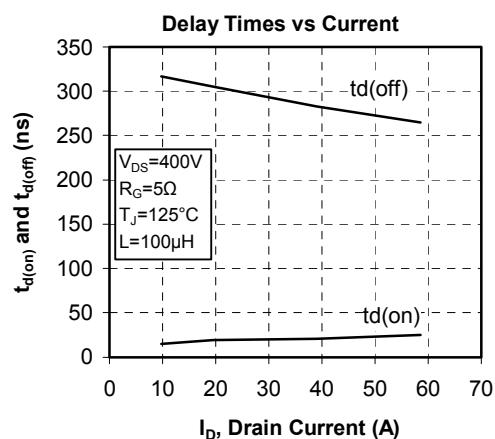
<i>Symbol</i>	<i>Characteristic</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
R ₂₅	Resistance @ 25°C		68		kΩ
B _{25/85}	T ₂₅ = 298.16 K		4080		K

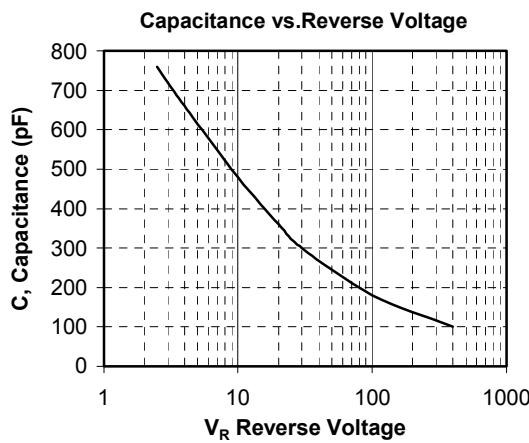
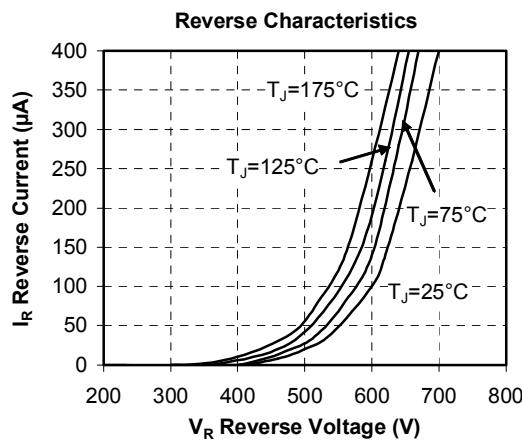
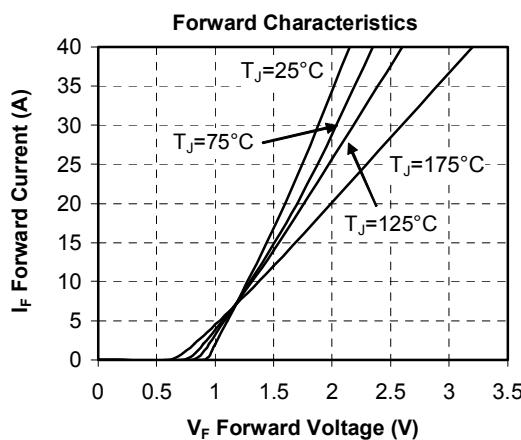
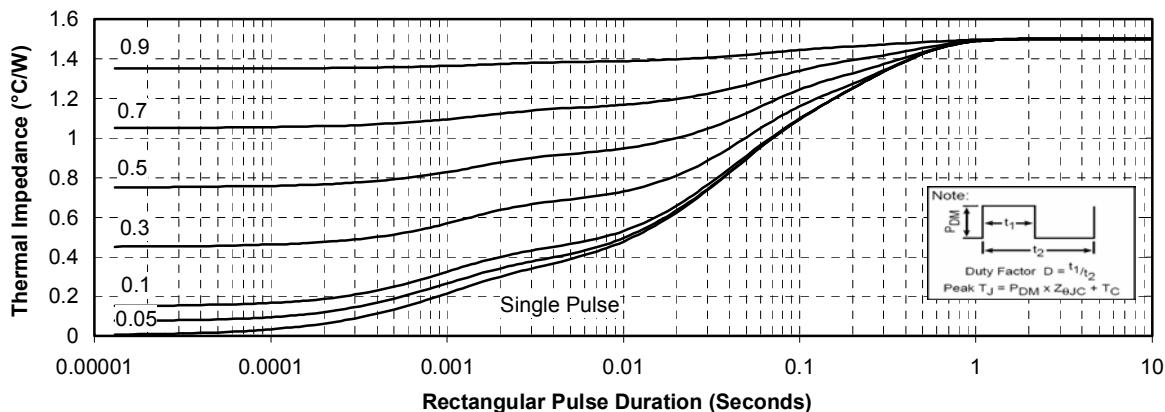
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad \begin{array}{l} T: \text{Thermistor temperature} \\ R_T: \text{Thermistor value at } T \end{array}$$

Package outline


Typical CoolMOS Performance Curve






Typical SiC Diode Performance Curve
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration


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APT's products are covered by one or more of U.S patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 and foreign patents. U.S and Foreign patents pending. All Rights Reserved.